EECS312-HW8:

Semiconductors

1. What is the concentration of free electrons and holes [#/cm³] of intrinsic silicon at 100K and 310K?

@100K: p= n = ni = $7.3 \times 10^{15} (100^{3/2}) \exp(-1.12/(2*8.62 \times 10^{-5} \times 100)) = 4.4596 \times 10^{-10}$ (essentially zero) @310K: p= n = ni = $7.3 \times 10^{15} (310^{3/2}) \exp(-1.12/(2*8.62 \times 10^{-5} \times 310)) = 3.15 \times 10^{10} [\#/cm^3]$

2. What is the conductivity and resistivity of intrinsic silicon at 100K and 310K?

@100K: σ = essentially zero, ρ = infinity [Ω cm] @310K: σ = 9.24x10-6 [1/(Ω cm)], ρ = 1.082x10⁵ [Ω cm]

3. A cylindrical resistor is constructed from intrinsic silicon at 310K having dimensions of radius=0.1cm and length 0.5cm. What is the value of the resistor?

@310K: R = $0.5*1.082 \times 10^5 / (\pi 0.1^2) = 1.72 \text{ M}\Omega$

4. Repeat 1-3 with doped silicon $N_D = 1 \times 10^{16} [\#/cm^3]$. (just for 310K)

@310K: n=1x10¹⁶ [#/cm³], p=1x10⁴ [#/cm³], σ = 2.16 [1/(Ω cm)], ρ = 0.46 [Ω cm], R = 7.36 Ω

5. Repeat 1-3 with doped P-type silicon $N_A = 1 \times 10^{16} [\#/cm^3]$. (just for 310K)

@310K: p=1x10¹⁶ [#/cm³], n=1x10⁴ [#/cm³], σ = 0.77 [1/(Ω cm)], ρ = 1.30 [Ω cm], R = 20.72 Ω

6. The distribution of free electrons in a N-type Silicon with at room temperature is given by the equation (use free electron mobility=2000 cm²/Vs and V_T =0.025V).

 $n(x)|_{t=0} = 1x10^{16}(cos(2\pi 100x) + 1)$ [#/cm³], where x is in units of cm.

What is the diffusion current density as a function of position (x) at t=0?

 $D_n = 2000*0.025 = 50 \text{ cm}^2/\text{s}$

 $J_n = q \cdot D_n \cdot n'(x) = 1.6 \times 10^{-19} [Coulombs] \cdot 50 [cm^2/s] \cdot (d/dx) 1 \times 10^{16} (cos(2\pi 100x) + 1) [\#/cm^3] [1/cm]$

 $J_n = 1.6x10^{-19} \cdot 50 \cdot 2\pi 100x10^{16} \cdot (-\sin(2\pi 100) \text{ [Coulombs]}[\text{cm}^2/\text{s}][\text{\#/cm}^3][\text{1/cm}]$

 $J_n = -16\pi \sin(2\pi 100)$ [Coulombs/cm²·s] or [Amps/cm²]